Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/654,893	HAYASE, KIYOSHI	
Examiner	Art Unit	
Joseph Schell	2114	

SEARCHED				
Class	Subclass	Date	Examiner	

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
		. .		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
IEEE - see search notes	5/15/2007	JS		
EAST - see search notes limited search 714/10,31,1-57	5/16/2007	JS		
		1		